



# EiceDRIVER<sup>™</sup>

### WCDSC006

### **Features**

- Independent High Side and Low Side TTL logic inputs
- 0.3 V to 7 V Input pin capability for increased robustness
- Integrated bootstrap diode
- Maximum bootstrap voltage of 60 V
- 2 A source/4 A sink current capability for high and low side drivers

### **Potential applications**

- Inductive wireless charger
- Qualified according Jedec Standard

### **Product validation**

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22.

## Description

The WCDSC006 is a half bridge driver designed to drive both high-side and low-side MOSFETs in a half-bridge inverter configuration. The floating high-side driver is capable of driving a high-side MOSFET operating up to 60 V bootstrap voltage. The high-side bias voltage is generated using a bootstrap technique. The inputs of the driver are TTL logic compatible and can withstand input voltages up to 7 V regardless of the VDD voltage. Even though high-side and low-side power device are driven independently, the driver enforces a 5 ns (typ) deadtime to prevent shoot-through. The WCDSC006 is available in PG-WSON-10 pins, with exposed pad, connected to ground, to aid power dissipation.



#### Figure 1



### Description

### Packages





### **Ordering information**

Base Part Number	Package Type	Standard Pack		Orderable Part	Marking Code	
		Form	Quantity	Number		
WCDSC006	PG-WSON-10	Tape and Reel	6000	WCDSC006XUMA1	EDrWCDS006	







### Table of contents

### Table of contents

	Features
	Potential applications
	Product validation
	Description
	Table of contents    3
1	Block diagram reference
2	Pin configuration
2.1	Pin assignment
2.2	Pin definitions and functions
3	<b>Electrical characteristics and parameters</b>
3.1	Absolute maximum ratings 6
3.2	Recommended operating conditions6
3.3	Static electrical characteristics6
3.4	Dynamic electrical characteristics7
3.5	Thermal mechanical characteristics    8
4	<b>Timing diagrams</b>
5	Typical characteristics
6	Functional description
6.1	Introduction
6.2	Supply voltage
6.3	Driver outputs
6.4	Undervoltage Lockout (UVLO) 13
6.5	Input configuration
6.6	Minimum On Time
6.7	Bootstrap capacitor design15
6.8	Anti-shoot through protection
6.9	Layout recommendations
7	Package information
7.1	Outline dimensions
7.2	Boardpads and apertures
7.3	Marking code
8	References
	Revision history
	<b>Disclaimer</b>



### 1 Block diagram reference

## 1 Block diagram reference

A simplified functional block diagram is given in the figure below.



Figure 2

Block diagram



### 2 Pin configuration

## 2 Pin configuration

### 2.1 Pin assignment



Figure 3

Pin configuration PG-WSON-10, top view

### 2.2 Pin definitions and functions

#### Table 1Pin definitions and functions

Pin	Symbol	Function
1	VDD	Gate drive supply
2	HB	High Side gate driver bootstrap rail
3	НО	High Side gate driver source and sink current output
4	HS	High Side FET source connection
5	NC	Not connected
6	NC	Not connected
7	HI	High Side driver control input
8	LI	Low Side driver control input
9	VSS	Ground return
10	LO	Low Side gate driver source and sink current output



#### **3 Electrical characteristics and parameters**

### 3 Electrical characteristics and parameters

### 3.1 Absolute maximum ratings

#### Table 2Absolute maximum ratings

Stresses above the listed values may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions may affect device reliability.

Parameter	Symbol	Va	lues	Unit	Note or Test	
		Min.	Max.	_	Condition	
High Side Bootstrap Voltage DC rating	V <sub>HB</sub>	_	60	V		
Bootstrap Supply Voltage	$V_{\rm HB}$ to $V_{\rm HS}$	-0.3	7	V	<i>T</i> <sub>C</sub> = 25°C	
Driver Supply Voltage	$V_{\rm DD}$ to $V_{\rm SS}$	-0.3	7	V	<i>T</i> <sub>C</sub> = 25°C	
Phase voltage to ground	V <sub>HS</sub>	-(9-V <sub>DD</sub> )	V <sub>HB</sub> +0.3	V		
Input voltage on HI and LI	V <sub>HI</sub> , V <sub>LI</sub>	-0.3	6	V		
Storage Temperature	T <sub>S</sub>	-55	150	°C		
Junction Temperature	T <sub>i</sub>	-55	150	°C		

### 3.2 Recommended operating conditions

#### Table 3 Recommended operating conditions

The following operating conditions must not be exceeded in order to ensure correct operation and reliability of the device. All parameters specified in the following tables refer to these operating conditions, unless noted otherwise.

Parameter	Symbol		Values			Note or Test
		Min.	Тур.	Max.		Condition
Phase Voltage to PGND	V <sub>HS</sub>	-(8-V <sub>DD</sub> )	-	V <sub>HB</sub> -V <sub>DD</sub>	V	
Driver Supply Voltage	V <sub>DD</sub>	4.75	-	5.5	V	
High Side Bootstrap Voltage	V <sub>HB</sub>	-	-	50	V	
Junction Temperature	TJ	-40	-	+125	°C	
Input voltage on HI and LI	V <sub>HI</sub> , V <sub>LI</sub>	0	-	5.5	V	

### 3.3 Static electrical characteristics

#### Table 4 Static electrical characteristics

 $V_{\text{DD}} = V_{\text{HB}} = 5 \text{ V}, V_{\text{HS}} = V_{\text{SS}} = 0 \text{ V}, T_{\text{C}} = 25^{\circ}\text{C}$  unless otherwise specified.

The  $V_{IN}$  and  $I_{IN}$  parameters are referenced to  $V_{SS}$ .

Parameter	Symbol		Values			Note or Test
		Min.	Тур.	Max.		Condition
V <sub>DD</sub> Supply UVLO Rising Threshold	UVLO <sub>VDD</sub>	3.7	4.1	4.5	V	



#### **3 Electrical characteristics and parameters**

#### Table 4 Static electrical characteristics (continued)

 $V_{DD} = V_{HB} = 5 \text{ V}, V_{HS} = V_{SS} = 0 \text{ V}, T_C = 25^{\circ}\text{C}$  unless otherwise specified. The  $V_{IN}$  and  $I_{IN}$  parameters are referenced to  $V_{SS}$ .

Parameter	Symbol		Values		Unit	Note or Test	
		Min.	Тур.	Max.		Condition	
V <sub>DD</sub> Supply UVLO Threshold Hysteresis	UVLO <sub>VDD,hys</sub>	-	0.2	-	V		
V <sub>HB</sub> Supply UVLO Rising Threshold	UVLO <sub>HB</sub>	3.5	3.9	4.3	V		
V <sub>HB</sub> Supply UVLO Threshold Hysteresis	UVLO <sub>HB,hys</sub>	-	0.2	-	V		
Boot voltage Quiescent Current	I <sub>QHB</sub>	-	-	200	μA	$V_{\rm LI} = V_{\rm HI} = 0 \rm V$	
Boot voltage Operating Current	I <sub>ОНВ</sub>	-	3.3	-	mA	f = 500  kHz $C_{\text{LOAD}} = 1 \text{ nF}$	
V <sub>DD</sub> Quiescent Current	I <sub>QDD</sub>	-	-	400	μA	$V_{\rm LI} = V_{\rm HI} = 0 \rm V$	
V <sub>DD</sub> Operating Current	I <sub>ODD</sub>	-	3.6	-	mA	f = 500  kHz $C_{\text{LOAD}} = 1 \text{ nF}$	
Input voltage high (HI and LI)	V <sub>H</sub>		2.3	2.6	V		
Input voltage low (HI and LI)	VL	1.3	1.5	-	V		
Input voltage Hysteresis	V <sub>HYST</sub>	-	0.8	-	V		
Input Pulldown Resistance	R <sub>IN</sub>	-	200	-	kΩ		
Peak Source current (HO and LO) <sup>(1)</sup>	I <sub>OHL</sub>	-	2	-	А		
Peak Sink Current (HO and LO) <sup>(1)</sup>	I <sub>OLL</sub>	-	4	-	А		
Pull down resistance	R <sub>PD</sub>	-	0.43	0.8	Ω		
Pull up resistance	R <sub>PU</sub>	-	1.07	2	Ω		
Bootstrap diode dynamic resistance	R <sub>D</sub>	-	2.7	-	Ω	I <sub>VDD-HB</sub> = 100 mA I <sub>VDD-HB</sub> = 1 mA	
Bootstrap forward voltage	V <sub>D</sub>	-	0.93	1.3	V	I <sub>VDD-HB</sub> = 100 mA	
Bootstrap diode revers recovery time <sup>(1)</sup>	T <sub>rr</sub>	-	50	-	ns	/ <sub>F</sub> = 20 mA / <sub>RR</sub> = 500 mA 7 <sub>C</sub> = 25°C	

#### (1) No subject of final test

### 3.4 Dynamic electrical characteristics

#### Table 5 Dynamic electrical characteristics

 $V_{\text{DD}} = V_{\text{HB}} = 5 \text{ V}, V_{\text{HS}} = V_{\text{SS}} = 0 \text{ V}, T_{\text{C}} = 25^{\circ}\text{C}$  unless otherwise specified.

Parameter	Symbol	Values			Unit	Note or Test
		Min.	Тур.	Max.	1	Condition
Turn on and Turn off propagation delay of Hi and Low <sup>(1)</sup>	$T_{\rm LH}/T_{\rm HL}$	-	40	-	ns	



#### **3 Electrical characteristics and parameters**

#### Table 5 Dynamic electrical characteristics (continued)

 $V_{\text{DD}} = V_{\text{HB}} = 5 \text{ V}, V_{\text{HS}} = V_{\text{SS}} = 0 \text{ V}, T_{\text{C}} = 25^{\circ}\text{C}$  unless otherwise specified.

Parameter	Symbol		Values		Unit	Note or Test
		Min.	Тур.	Max.	_	Condition
The delay matching LI to LO and HI to HO, both rising and falling <sup>(2)</sup>	DELM	-	1	8	ns	Gate Driver; V <sub>LI</sub> = 0 V & V <sub>HI</sub> = 5 V with no external deadtime
Minimum dead time between HI, LI <sup>(2)</sup>	T <sub>deadtime</sub>	-	5	-	ns	$C_{\rm LOAD} = 0  \rm nF$
Minimum input pulse width that changes the output	T <sub>pw</sub>	-	-	20	ns	
HO rise time	T <sub>HRC</sub>	-	3	-	ns	$C_{\rm LOAD} = 1  \rm nF$
LO rise time	T <sub>LRC</sub>	-	3	-	ns	
HO fall time	T <sub>HFC</sub>	-	2	-	ns	
LO fall time	T <sub>LFC</sub>	_	2	-	ns	

(1) A transient detector blocks the toggling of the high side output when it detects moving phase node (due to transition and/or oscillation). It prevents unwanted re-toggling but may increase propagation delay. See *Figure 6* and *Figure 7* for more information and link to *Understanding the transient detector* (*References*) for more information.

(2) No subject of final test

### 3.5 Thermal mechanical characteristics

#### Table 6Thermal mechanical characteristics

Parameter	Symbol	Values			Unit	Note or Test
		Min.	Тур.	Max.		Condition
Junction to Case Thermal Resistance	R <sub>thJC</sub>	-	7	-	°C/W	Bottom
		-	20	-	°C/W	Тор
Device on PCB	R <sub>thJA</sub>	-	40	-	°C/W	6 cm <sup>2</sup> cooling area <sup>(1)</sup>

(1) Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 μm thick) copper area for drain connection. PCB vertical in still air.



### 4 Timing diagrams

4 Timing diagrams





UVLO behavior



#### Figure 6 Transient detector response





Transient detector slew rate thresholds vs. temperature



#### **5** Typical characteristics

5

**Typical characteristics** 







#### **5** Typical characteristics





140

-0.4

-0.5 ∟ -40

-20

0

20

40

Temperature, T [°C]

60

80

100

120



#### **5** Typical characteristics







Temperature,  $T [^{\circ}C]$ 

6 Functional description



### 6 Functional description

### 6.1 Introduction

The WCDSC006 is a fast Half-Bridge driver for both high-side and low-side MOSFETs in a wireless charging halfbridge inverter configuration. The focus on robustness at the input and output side additionally gives this device a safety margin in critical abnormal situations. All outputs are robust against reverse current. The interaction with the power MOSFET, even reverse reflected power will be handled by the strong internal output stage. All inputs are compatible with LV-TTL signal levels, signal delays and rise/fall times have been minimized.

### 6.2 Supply voltage

The absolute maximum supply voltage is 7 V. The minimum operating supply voltage is set by the undervoltage lockout function to a typical default value of 4.1 V. This lockout function protects power MOSFETs from running into linear mode with subsequent high power dissipation.

### 6.3 Driver outputs

This driver output stage has a shoot through protection and current limiting behavior. After a switching event, current limitation is raised up to achieve the typical current peak for an excellent fast reaction time of the following power MOS transistor. The output impedance is very low with a typical value below 1.07  $\Omega$  for the sourcing p-channel MOS and 0.43  $\Omega$  for the sinking n-channel MOS transistor. Gate Drive Outputs held active low in case of floating inputs VHI, VLI or during startup or power down once UVLO is not exceeded. Under any situation, startup, UVLO or shutdown, outputs are held under defined conditions.

### 6.4 Undervoltage Lockout (UVLO)

The Undervoltage Lockout function ensures that the output can be switched to its high level only if the supply voltage exceeds the UVLO threshold voltage. Thus it can be guaranteed, that the switch transistor is not switched on if the driving voltage is too low to completely switch it on, thereby avoiding excessive power dissipation. The UVLO level is set to a typical value of 4.1 V. The max value of the rising edge is the value that ensures all the device among the production will be turned on during start up; that means designers have to provide a voltage higher than 4.5 V to turn on all the devices in the production of their equipment within the specified temperature range.

On the opposite side the minimum voltage necessary to switch off all the devices is the minimum of the falling edge. Therefore to be sure that all the devices in production will be turned off, in the specified temperature range, a voltage lower than 3.5 V has to be provided.

The hysteresis is the voltage gap between rising edge and falling edge. The UVLO function is implemented for both VDD and HB; this ensures some margin on noise effect, like false turn off. For instance a negative glitch smaller than the hysteresis will not have effect on the device preventing an unwanted turn off.

### 6.5 Input configuration

The inputs HI and LI control two PWM channels. The input signal is transferred non-inverted to the corresponding gate driver outputs HO and LO. All inputs are compatible with LV-TTL threshold levels and provide a hysteresis of typ. 0.8 V. The hysteresis is independent of the supply voltage VDD. The PWM inputs are internally pulled down to a logic low voltage level (GND). In case the PWM-controller signals have an undefined state during the power-up sequence, the gate driver outputs are forced to the "off"-state(low). *Table 7* shows the truth table of the device once the two UVLOs are turned on; in case the VDD-GND voltage or the HB-HS voltage is below the UVLO threshold the corresponding output will be low.

(1)

#### 6 Functional description

Table 7Truth table with VDD-GND and HB-HS higher than UVLO threshold						
н	LI	НО	LO	Notes		
Н	Н	n.a.	n.a.	See note on the anti shoot-through protection		
Н	L	Н	L			
L	L	L	L			
L	Н	L	Н			
Х	Х	L	L			

### 6.6 Minimum On Time

The minimum On time is the minimum duration of the input pulse which is generating an output pulse. The upper limit is the pulse width at which all the drivers in production will provide an output signal. In other words the designer has to provide a pulse width longer than the upper limit of the minimum on time to ensure an output pulse for every driver of their equipment.

The upper limit of this parameter is determining the maximum switching frequency of the converter according to the formula:

$$t_{\rm SW_{max}} = \frac{V_{\rm IN} \times t_{\rm ON_{max}} \times k}{V_{\rm OUT}}$$

Where  $V_{\text{IN}}$  is the input voltage,  $V_{\text{OUT}}$  is the desired output voltage  $t_{\text{ONmax}}$  is the upper limit of the minimum on time and k is the transformer ratio.

There is a nonlinear transfer function between the inputs (HI, LI) and the outputs gate signals (HO, LO) represented in *Figure 8*.



#### Figure 8

#### Input output transfer characteristic

For input pulses shorter than 20 ns pulse width (the grey area) the driver does not guarantee that the input pulse will be transferred to the output, depending on the device the input pulse might go through and generate an output pulse or it might not go through and therefore not generating an output pulse. For input pulses with pulse width smaller than 30 ns the output pulse is kept to 30 ns, then the response will be linear (shifted by the propagation delay). This is diagram is illustrative only with typical value. Actual value and pulse width distortion is subject to process variation. Output pulse width could in some case be shortened or extended to prevent retoggling. See propagation delay parameter footnote.

# 6 Functional description

EiceDRIVER<sup>®</sup> WCDSC006

Table 8Table 2	Output pulse width vs input pulse width
Input pulse width	Output pulse width
Smaller than 20 ns	<ul> <li>In the case the driver is capable to transfer the pulse, the output pulse width is 30 ns</li> <li>In case the driver is not capable of responding the output pulse is 0 ns</li> </ul>
Between 20 ns and 30 ns	The output pulse width is 30 ns
Above 30 ns	The output pulse width is equal to input pulse width

### 6.7 Bootstrap capacitor design

The bootstrap capacitor is used to power the floating driver of the high side MOSFET. Therefore it has to provide the surge current and the charge to turn on the high side MOSFET. Normally a criteria to choose the minimum necessary boot capacitor is based on the gate charge of the high side and allowed ripple voltage across the boot capacitor, according to the following formula:

(2)

$$C_{\text{BOOTmin}} \ge \frac{Q_G}{\Delta V}$$

Where  $Q_G$  is the gate charge of the high side MOSFET and  $\Delta V$  is the desired ripple voltage. Normally a rule of thumb for the ripple voltage is to have it smaller than 10% than the bootstrap voltage. This is a simplified formula which does not consider the leakage current of the floating driver, the bootstrap diode forward voltage but it is correct for most of the applications.

There is also an upper limit in the selection of the capacitor since a too big capacitor would lead to higher charging time which could result in startup issues due to the UVLO triggering. This problem can arise if the switching frequency is very high and therefore the time to charge the bootstrap is too short. For this kind of issues there is not a clear formula to apply, but some generic rules can be considered compatible with the  $C_{\text{BOOTmin}}$  calculation:

- The higher the switching frequency the smaller should be the bootstrap capacitor
- The higher the MOSFET RDS<sub>(ON)</sub> the smaller should be the bootstrap capacitor
- The higher the V<sub>DD</sub> the smaller should be the bootstrap capacitor (considering a fixed ripple voltage percentage)

### 6.8 Anti-shoot through protection

In order to prevent conditions where the high side MOSFET and the low side MOSFET are turned on at the same time an anti-shoot through logic is implemented with an addition of 3 ns deadtime. In other words the first input detected high, for instance HI will set the HO output high, meanwhile the LI will be inhibited until the HI input will not expire, then LI signal will be passed with additional 3 ns deadtime safety.

This logic prevents the HI and LI to be driven by the same signal. In this case the internal logic will select the "first" pulse coming in (depending on the specific parasitic of the device, the selection of the "first" signal might change) and inhibit the "second". This logic is not suitable for driving parallel MOSFET with HO and LO.

### 6.9 Layout recommendations

The combination of the driver and MOSFETs forms the power trains of the converter. The relative location on the PCB of those two components together with the input capacitor is essential to reach high level of performance. The parasitic inductances of the PCB and of the power devices' packaging (both upper and lower MOSFETs) can cause serious efficiency degradation due to dynamic effects. Careful layout can help minimize such unwanted effects. The following advices are meant to lead to an optimized layout:



#### **6 Functional description**

- 1. Keep decoupling loops (VDD-GND and HB-HS) as short as possible
- 2. Minimize trace inductance, especially on low impedance lines. All power traces (HO, HS, LO, PGND, VDD) should be short and wide, as much as possible
- **3.** The HS node should also be short and wide. Minimize the distance between the HS node and both the high side MOSFET source and the low side MOSFET drain to avoid efficiency losses minimize the current loop of the output and input power trains. Short the source connection of the lower MOSFET to ground as close to the transistor pin as feasible. Input capacitors (especially ceramic decoupling) should be placed as close to the drain of upper and source of lower MOSFETs as possible
- **4.** To optimize heat spreading, copper should be placed directly underneath the IC whether it has an exposed pad or not. The copper area can be extended beyond the bottom area of the IC and/or connected to buried copper plane(s) with thermal vias. This combination of vias for vertical heat escape, extended copper plane, and buried planes for heat spreading allows the IC to achieve its full thermal potential



7 Package information

### 7.1 Outline dimensions





#### 7 Package information

Dimension Table				
Thickness Symbol	W			NOTE
- mbol	MINIMUM	NOMINAL	MAXIMUM	
A	0.70	0.75	0.80	
A1	0.00	0.02	0.05	
A3		0.20 Ref.		
Ь	0.25	0.30	0.35	5
D		4.00 BSC		
E		4.00 BSC		
е		0.80 BSC		
D2	2.85	3.00	3.10	
E2	2.45	2.60	2.70	
к	0.20			
L	0.30	0.40	0.50	
aaa		0.05		
ьрр	0.10			
CCC	0.10			
ddd	0.05			
eee	0.08			
N	10			3
ND	5			7
NOTES	1, 2			
LF DWG. NO.	CSM7/13/2016-001			

#### NOTE:

- 1. Dimensioning and tolerancing conform to ASME Y14.5-2009.
- 2. All dimensions are in millimeters.
- 3. N is the total number of terminals.

4. The location of the marked terminal #1 identifier is within the hatched area.

5. Dimension b applies to the metallized terminal and is measured from 0.15mm and 0.30mm from the terminal tip. If the terminal has a radius on the other end of it, dimension b should not be measured in that radius area.

6. Coplanarity applies to the terminals and all other bottom surface metallization.

7. ND refers to the maximum number of terminals on D side.



### 7 Package information

### 7.2 Boardpads and apertures





### 7 Package information







#### 8 References

## 8 References

**1.** Infineon, *Understanding the transient detector*, Infineon Technologies AG, Neubiberg 2020

### **Revision history**

# **Revision history**

Document versionDate of releaseV2.22020-05-28		Description of changes		
		<ul> <li>Update of typical value of <i>DELM</i> in <i>Dynamic electrical characteristi</i></li> <li><i>Typical characteristics</i> added</li> </ul>		
V2.1	2020-04-22	Update to new template		
V2.0	2019-09-17	Initial release		

#### Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

Edition 2020-05-28 Published by Infineon Technologies AG 81726 Munich, Germany

© 2020 Infineon Technologies AG All Rights Reserved.

Do you have a question about any aspect of this document? Email: erratum@infineon.com

Document reference IFX-ykn1580889052252

#### **IMPORTANT NOTICE**

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie").

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

#### WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.